

<b>Notice of References Cited</b>	Application/Control No. 10/531,208		Applicant(s)/Patent Under Reexamination UEDA ET AL.	
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*		Document Number Country Code-Number-Kind Code	Date MM-YYYY	Name	Classification
*	A	US-2003/0211421	11-2003	Hanabata et al.	430/285.1
*	B	US-5,124,233	06-1992	Meier et al.	430/280.1
	C	US-			
	D	US-			
	E	US-			
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	G	US-			
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	I	US-			
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	K	US-			
	L	US-			
	M	US-			

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	N	JP10-310545 A	11-1998	Japan	Ueda	N/A
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#### NON-PATENT DOCUMENTS

*		Include as applicable: Author, Title Date, Publisher, Edition or Volume, Pertinent Pages)
	U	Machine-assisted English translation of JP 10-310545 provided by JPO.
	V	Machine-assisted English translation of JP 2002-229193 provided by JPO.
	W	
	X	

\*A copy of this reference is not being furnished with this Office action. (See MPEP § 707.05(a).)  
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